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OPTIMAL-TRANSPORT-BASED METRIC FOR SMLM

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ABSTRACT

We propose the use of Flat Metric to assess the performance of reconstruction methods for single-molecule localization microscopy (SMLM) in scenarios where the ground-truth is available. Flat Metric is intimately related to the concept of optimal transport between measures of different mass, providing solid mathematical foundations for SMLM evaluation and integrating both localization and detection performance. In this paper, we provide the foundations of Flat Metric and validate this measure by applying it to controlled synthetic examples and to data from the SMLM 2016 Challenge.

1 Introduction

Single-molecule localization microscopy (SMLM) has boomed over the past decade, delivering on the promise of breaking the diffraction limit and giving access to otherwise unreachable cellular structures [1, 2]. SMLM relies on computational methods that detect and accurately localize the few fluorescent emitters in each of many acquired frames, ultimately creating a superresolved image (up to 10nm) [3]. Therefore, it is crucial to have at one’s disposal an objective evaluation of the recovery performance of available reconstruction algorithms. The present paper studies this topic, under the hypothesis that a ground-truth reference for every captured frame is available. Metrics that do not require ground-truth information also exist [4–7], even some using optimal transport concepts [8]. However, these are outside of the scope of this paper, and our proposal is completely new. Similarly, simpler optimal-transport-based metrics were used before in other point-source localization problems [9, 10].

The localization of point sources is traditionally assessed using either detection metrics, such as precision, recall, and the Jaccard index; or localization metrics, such as the root-mean-square error (RMSE) or the root-mean-square minimum distance (RMSMD) [11]. In the SMLM 2016 Challenge [3], a large panel of metrics was computed for performance assessment. The participating localization algorithms typically focused on one of two main key metrics: the Jaccard index (J) or the root-mean-square error (RMSE). To encompass both, Sage *et al.* proposed the efficiency, a metric born from the analysis of the empirical results in [3] and designed to evaluate the SMLM 2016 Challenge. It is computed as

$$\text{efficiency} = 100 - \sqrt{(100 - J)^2 + \alpha_{\text{eff}}^2 \text{RMSE}^2}. \quad (1)$$

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The parameter α_{eff} was introduced to regulate the tradeoff between localization and detection. It was set to $\alpha_{\text{eff}} = 1\text{nm}^{-1}$ for the two-dimensional (lateral) efficiency after analysis of the results for the best algorithms. With this empirical choice, an improvement of 1nm in RMSE is equivalent to a 1% improvement in J.

In this paper, we propose to use *Flat Metric*, also known in the literature as the flat norm or the Kantor-Rubinstein norm [12–15], to assess the recovery performance of algorithms for SMLM. This metric has already been used to assess the recovery performance of point source signals [16]. It can be related to optimal transport which is a well-studied field both on a theoretical [17, 18] and numerical [13] standpoint. By using a valid metric on the space of Radon measures, in which detections and ground-truth data lie, we expose the natural connection between the localization-detection performance tradeoff and the radius of tolerance used to judge a detected location as correct or incorrect. Furthermore, like other metrics introduced recently for SMLM [11], Flat Metric does not require arbitrary pairing decisions between detected and ground-truth locations. Nonetheless, in opposition to RMSMD, Flat Metric still resolves pairings implicitly, thus yielding interpretable and explainable assessments.

The paper is structured as follows: First, we introduce Flat Metric mathematically, expose its link with unbalanced optimal transport and explain how to compute it numerically. Then, we illustrate its behavior on a simple example. Finally, we compare it to the efficiency (1) on both synthetic data and the SMLM 2016 challenge data.

2 Flat Metric for SMLM

2.1 Mathematical Definition

Without loss of generality, we assume that the ground-truth and detected locations are in $\mathcal{X} = [0, 1]^D$, for $D \in \{2, 3\}$. We use the Euclidean distance $d(\mathbf{x}, \mathbf{y}) = \|\mathbf{x} - \mathbf{y}\|_2$ to measure the distances between two points. We denote by $\mathcal{M}(\mathcal{X})$ the space of Radon measures defined on \mathcal{X} . Mathematically, $\mathcal{M}(\mathcal{X})$ is the continuous dual of the space $\mathcal{C}(\mathcal{X})$ of continuous functions on \mathcal{X} endowed with the uniform norm $\|\cdot\|_\infty$. The canonical norm on $\mathcal{M}(\mathcal{X})$ is thus

$$\forall \mu \in \mathcal{M}(\mathcal{X}), \quad \|\mu\|_{\mathcal{M}} \triangleq \sup_{f \in \mathcal{C}(\mathcal{X}), \|f\|_\infty \leq 1} \int_{\mathcal{X}} f d\mu, \quad (2)$$

and is known as the total-variation norm or \mathcal{M} norm. The Banach space $\mathcal{M}(\mathcal{X})$ contains point-source signals, referred to as the Dirac masses $\delta_{\mathbf{x}} \triangleq \delta(\cdot - \mathbf{x})$ for $\mathbf{x} \in \mathcal{X}$. This makes it particularly well-suited for SMLM because individual fluorescent emitters can be seen

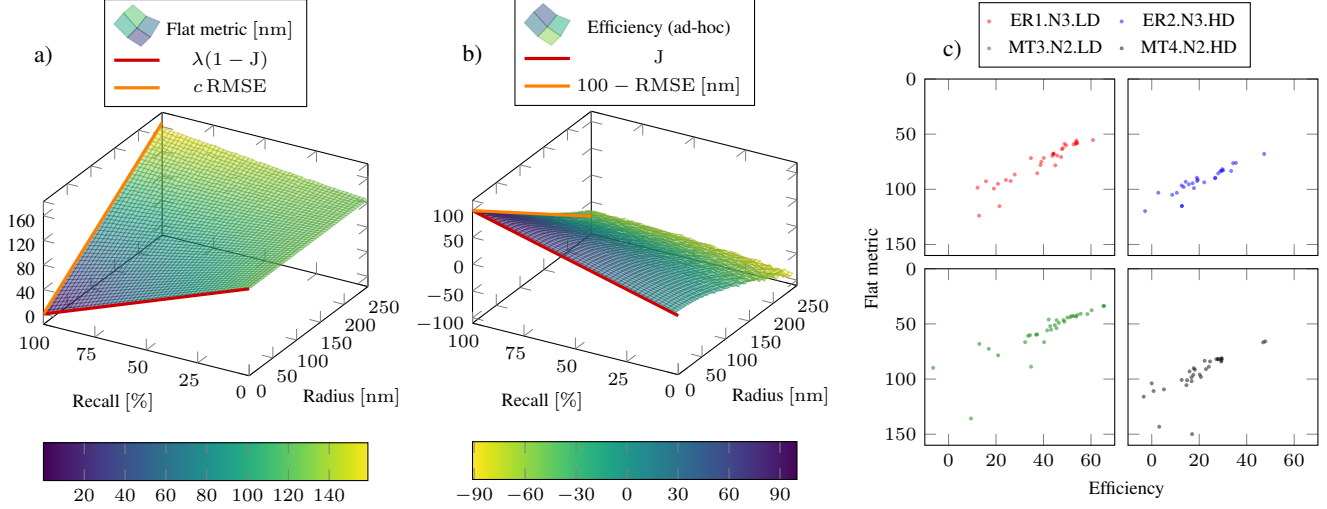


Fig. 1: a) Flat Metric (low: good). b) Efficiency (low: bad). These metrics take into account a continuum in both localization and detection errors in SMLM. Locations (100) were uniformly drawn to create ground-truth points and modified to create artificial sets of detections with 100% precision, recall ranging from 0% to 100%, and localization errors uniformly sampled in a circle of a given radius. c) High degree of correlation between efficiency and Flat Metric on four datasets from the SMLM 2016 Challenge.

as Dirac masses, which suggests the representation of SMLM data as sums of Dirac masses.

The total-variation norm is not a good candidate metric for SMLM because, for all $\mathbf{x} \neq \mathbf{y}$, $\|\delta_{\mathbf{x}} - \delta_{\mathbf{y}}\|_{\mathcal{M}} = 2$. Instead, we build our metric from the flat norm on $\mathcal{M}(\mathcal{X})$ given in Definition 1.

Definition 1 (Flat norm [14]). *The flat norm of a given $\mu \in \mathcal{M}(\mathcal{X})$ is defined as*

$$\|\mu\| \triangleq \sup \left(\left\{ \int_{\mathcal{X}} f d\mu : f \in \mathcal{C}(\mathcal{X}), \|f\|_{\infty} \leq \lambda, \text{Lip}(f) \leq 1 \right\} \right), \quad (3)$$

where $\text{Lip}(f)$ is the Lipschitz constant of f . This definition induces a norm on $\mathcal{M}(\mathcal{X})$.

Using the flat norm to measure the difference between two Radon measures leads to Flat Metric.

Definition 2 (Flat Metric). *Flat Metric is defined for any two $\mu, \nu \in \mathcal{M}(\mathcal{X})$ as*

$$F_{\lambda}(\mu, \nu) \triangleq \|\mu - \nu\|. \quad (4)$$

Flat Metric is linked to unbalanced optimal transport [13, 19]. This makes Flat Metric interpretable, which is key for its application to SMLM.

Proposition 1 (Interpretation of Flat Metric - [19], Prop. 2.26). *For all $\mu, \nu \in \mathcal{M}(\mathcal{X})$,*

$$F_{\lambda}(\mu, \nu) = \min_{\pi \in \mathcal{M}_{+}(\mathcal{X} \times \mathcal{X})} \left\{ \int_{\mathcal{X} \times \mathcal{X}} d(\mathbf{x}, \mathbf{y}) d\pi(\mathbf{x}, \mathbf{y}) + \lambda \left\| \mu - \text{pr}_{\mathbf{x}\#} \pi \right\|_{\mathcal{M}} + \lambda \left\| \nu - \text{pr}_{\mathbf{y}\#} \pi \right\|_{\mathcal{M}} \right\}, \quad (5)$$

where $\pi \in \mathcal{M}_{+}(\mathcal{X} \times \mathcal{X})$ is a nonnegative Radon measure over $[0, 1]^D \times [0, 1]^D$ that specifies the transport plan between the

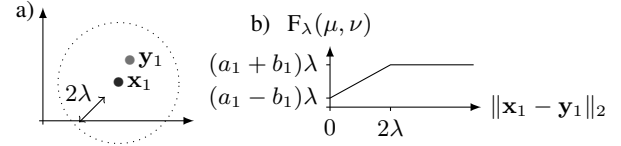


Fig. 2: a) Example of two discrete measures in $\mathcal{X} = [0, 1]^2$, $\mu = a_1 \delta_{\mathbf{x}_1}$ and $\nu = b_1 \delta_{\mathbf{y}_1}$, where a_1 and b_1 are represented by the opacity of the \bullet marks. b) Dependence of the metric $F_{\lambda}(\mu, \nu)$ on $\|\mathbf{x}_1 - \mathbf{y}_1\|_2$ from a) for fixed values $a_1 > b_1$, growing linearly with $\|\mathbf{x}_1 - \mathbf{y}_1\|_2$ and saturating at $\|\mathbf{x}_1 - \mathbf{y}_1\|_2 = 2\lambda$.

marginals $\text{pr}_{\mathbf{x}\#} \pi = \int_{\mathcal{X}} d\pi(\cdot, \mathbf{y})$ and $\text{pr}_{\mathbf{y}\#} \pi = \int_{\mathcal{X}} d\pi(\mathbf{x}, \cdot)$ of π (which can be made arbitrary close to μ and ν , respectively, by setting $\lambda \rightarrow +\infty$).

The first term in the minimization problem (5) penalizes the cost of transporting $\text{pr}_{\mathbf{x}\#} \pi$ to $\text{pr}_{\mathbf{y}\#} \pi$ (or vice versa). This is, in fact, the same cost function as in the 1-Wasserstein distance, one of the classical optimal-transport problems. Optimal-transport metrics quantify how different two measures are by assessing the cost of transforming (in other words, transporting) one measure onto the other. Unlike in standard optimal transport, the marginals $\text{pr}_{\mathbf{x}\#} \pi$ to $\text{pr}_{\mathbf{y}\#} \pi$ need not be equal to the measures of interest μ and ν . Instead, the constraints are relaxed using the second and third discrepancy terms in (5) which involve the total-variation norm. This relaxation allows for the creation and destruction of mass before transport and, therefore, for an optimal transport between measures with different total mass. This key feature is essential for SMLM, as it accounts for the errors both of localization (by the cost of transport) and of detection (by the cost of creation or destruction of mass). Their balance is controlled by the physically interpretable parameter $\lambda > 0$ [nm], as illustrated in Figure 2. When the two Dirac masses are at the same position, the cost is proportional to the difference of weights. Then, it grows linearly with $\|\mathbf{x}_1 - \mathbf{y}_1\|_2$ as the Dirac mass $b_1 \delta_{\mathbf{y}_1}$ is transported to the position \mathbf{x}_1 . This keeps happening until $\|\mathbf{x}_1 - \mathbf{y}_1\|_2 \geq 2\lambda$, where

the masses are no longer moved and the cost results from the pure creation and destruction of mass.

It is also important to note that Flat Metric is homogeneous to nanometers so that it can be physically associated to a specific scale (in nanometers for the SMLM problem). Hence, when the number of locations is estimated correctly, Flat Metric represents the mean error in terms of localization, similar to the RMSE (see Figure 1). When $\lambda \rightarrow +\infty$ and μ and ν have the same mass, we recover the 1-Wasserstein distance ($\|\cdot\|_{W_1}$). Finally, when $\lambda \rightarrow 0$, we recover the total-variation norm. Consequently, Flat Metric is an interpolating distance between $\|\cdot\|_{W_1}$ and $\|\cdot\|_{\mathcal{M}}$.

2.2 How to Compute Flat Metric

The ground-truth data can be represented as the discrete Radon measure

$$\mu = \sum_{n=1}^N a_n \delta_{\mathbf{x}_n} \in \mathcal{M}(\mathcal{X}) \quad \text{with} \quad a_n > 0, \mathbf{x}_n \in \mathcal{X}, \quad (6)$$

which contains the locations of the fluorescent emitters in a frame. The reconstructed locations given by any software can also be represented as the discrete Radon measure

$$\nu = \sum_{m=1}^M b_m \delta_{\mathbf{y}_m} \in \mathcal{M}(\mathcal{X}) \quad \text{with} \quad b_m > 0, \mathbf{y}_m \in \mathcal{X}. \quad (7)$$

In this discrete setting, we simplify the computation of Flat Metric $F_\lambda(\mu, \nu)$ in (4) as detailed in Proposition 2.

Proposition 2. *When μ and ν are discrete Radon measures, one can compute (4) as*

$$F_\lambda(\mu, \nu) = - \min_{\mathbf{f} \in \mathbb{R}^{N+M} \text{ s.t. } \mathbf{L}\mathbf{f} \in \mathcal{B} \times \mathcal{C}} \langle \mathbf{f}, -\mathbf{c} \rangle, \quad (8)$$

where $\mathbf{L} : \mathbb{R}^{N+M} \rightarrow \mathbb{R}^{N \times M} \times \mathbb{R}^{N+M}$ is defined by

$$\mathbf{L}\mathbf{f} = \left((\mathbf{f}_n - \mathbf{f}_{N+m})_{1 \leq n \leq N, 1 \leq m \leq M}, \mathbf{f} \right), \quad (9)$$

where $\mathbf{c} = (\mathbf{a}, -\mathbf{b}) \in \mathbb{R}^{N+M}$, and \mathcal{B} and \mathcal{C} are hyper-rectangles such that $\mathcal{B} = \{\mathbf{G} \in \mathbb{R}^{N \times M}; |G_{n,m}| \leq d(\mathbf{x}_n, \mathbf{y}_m)\}$ and $\mathcal{C} = \{\mathbf{f} \in \mathbb{R}^{N+M} : \forall k \in \{1, 2, \dots, N+M\}, |f_k| \leq \lambda\}$.

In fact, (8) holds because the dual problem of that minimization is exactly the unbalanced optimal transport problem (5) for discrete measures, and strong duality holds.

Therefore, to compute $F_\lambda(\mu, \nu)$, one simply needs to solve the minimization problem given in (8), which is a finite-dimensional linear program. This problem is then solved using any standard linear programming toolbox.

Note that if one considers only the first part of the operator \mathbf{L} in (9) then (8) is exactly the dual problem of the 1-Wasserstein optimal transport problem, see [13, ch. 6]. The second part accounts for the relaxation allowing creation and destruction of mass, as explained above.

3 Numerical Experiments

In this section, we first propose an example to illustrate the behavior of Flat Metric. Then, we detail how we generated Figure 1, which

confirms that Flat Metric has a behavior similar to that of the efficiency [3] and that it provides a continuum between detection and localization errors. Finally, we report Flat Metric as obtained by 31 participants of the SMLM 2016 Challenge on the 2D dataset and compare it with their efficiency and RMSMDs. Note that, in all our experiments, the weights of the ground-truth are uniform and the obtained scale is applied for the reconstruction, with $a_n = b_m = 1/N$. We use the normalizing scaling of the ground-truth for the reconstruction as it provides a coherent way to compare different software which do not detect the same number of point sources.

3.1 Interpretation of Flat Metric

We show in Figure 3 an example of a ground-truth dataset (●), and its reconstructed dataset (●), and how Flat Metric accounts for the difference between these two measures. Ground-truth locations were chosen randomly in the rectangle $[0, 1] \times [0, 0.5]$ with weights $a_n = b_m = 1/N$ with $N = 15$. Here, $\lambda = 0.1$, which constrains the maximal transport distance between two isolated point sources to 0.2 (see Figure 2). Our interpretation of Flat Metric comes from its link with unbalanced optimal transport (see Proposition 1). As a metric, it is symmetric. Therefore, we arbitrarily choose to interpret it as the cost of transporting the estimation towards the ground truth (GT). As a result, we have the following behaviors.

- *Transport:* A Dirac mass $\delta_{\mathbf{y}}/N$ of the reconstruction is moved towards one in the ground-truth data $\delta_{\mathbf{x}}/N$. The cost of this transport is $d(\mathbf{x}, \mathbf{y})/N$.
- *Destruction of mass:* A Dirac mass $\delta_{\mathbf{y}}/N$ of the reconstruction is destroyed because there is no corresponding ground-truth location nearby. The cost of this destruction of mass is $\lambda \|\delta_{\mathbf{y}}/N\|_{\mathcal{M}} = \lambda/N$.
- *Creation of mass:* A Dirac mass $\delta_{\mathbf{y}}/N$ is created at a position \mathbf{y} to match a ground-truth location when there is no corresponding Dirac mass in the reconstruction. This cost is λ/N .

Note that we have only these three alternatives because of our choice of weights. To have more complex phenomena such as simultaneous transport, creation, and destruction of mass, discrete measures with Dirac masses of different weights should be used. This could certainly be of interest to the evaluation of other point-source localization problems.

3.2 Synthetic Experiments on Flat Metric and Efficiency

We show in Figure 1 how Flat Metric, just as efficiency, interpolates between detection and localization metrics. To its benefit, Flat Metric has strong foundations in the theory briefly presented in Section 2, by contrast with the efficiency measure which is based on empirical results. Consistently, Flat Metric is also well-defined for 0% recall, thus being a robust tool for any use-case.

In order to exhibit this link in conditions relevant to SMLM, we chose to focus on recall as a detection metric. Indeed, recall is typically the most relevant factor to characterize detection in SMLM, as most leading algorithms achieve very high precision [3]. We modeled this situation by randomly sampling 100 ground-truth locations uniformly in a square of $(6.4 \times 6.4) \mu\text{m}$, and simply removing the corresponding percentage of locations to initialize the set of recovered locations.

For the joint evaluation of detection and localization effects, we modeled localization errors in detected locations as independent

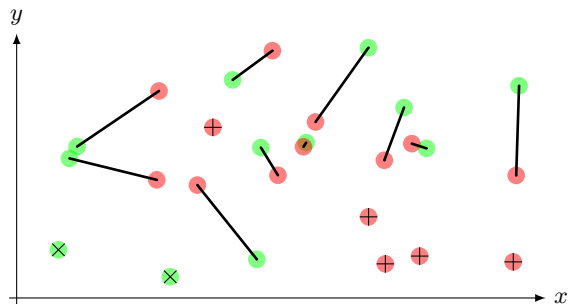


Fig. 3: Illustration of how Flat Metric (here equal to 0.125) is computed. When an estimated location (●) is linked by a line to a ground-truth location (●), the cost ($d(\mathbf{x}, \mathbf{y})/N$) comes from moving the former to the latter. The presence of a cross (×) means that the point has been destroyed, at the cost of λ/N . A ground-truth location with a plus sign (+) means a mass has been created at this position to match it, also at the cost of λ/N .

and identically distributed uniform vectors in disks of radius up to 250 nm.

The results in Figure 1 were generated by averaging 50 randomized trials for each combination of radius and recall, using $\lambda = 125$ nm. Finally, the expectations of Flat Metric and efficiency are shown on the planes with 100% recall and vanishing perturbation radius, respectively. They are related to the expectations of J and RMSE in those cases, where $c = 2/3\sqrt{2}$.

3.3 Application to the 2016 Challenge

We compare efficiency, a thoroughly validated empirical metric for SMLM, to both Flat Metric and RMSMD, on four 2D datasets from the SMLM 2016 Challenge¹. As shown in Figures. 1 and 4, Flat Metric is strongly correlated with efficiency, while RMSMD is not. Indeed, one only observes few outliers on the efficiency vs. Flat Metric comparison, mainly for reconstruction methods that work rather poorly on the datasets MT3 and MT4.

4 Conclusion

We propose Flat Metric to quantitate SMLM reconstruction errors when ground-truth data are available. Here, we present and exemplify the strong links between Flat Metric and unbalanced optimal transport problems, which underpin this robust metric. We also provide exhaustive evidence that Flat Metric is conceptually similar to efficiency, a very well established empirical metric designed in the organization of the SMLM 2016 Challenge. Consequently, we provide a robust and practical metric for SMLM evaluation. We have also exemplified and explained how Flat Metric works internally, providing intuition on how this optimal assessment is obtained. Further, we have emphasized the interpretability of Flat Metric, which can be read as an equivalent localization accuracy.

¹<http://bigwww.epfl.ch/smlm/challenge2016/index.html?p=results>

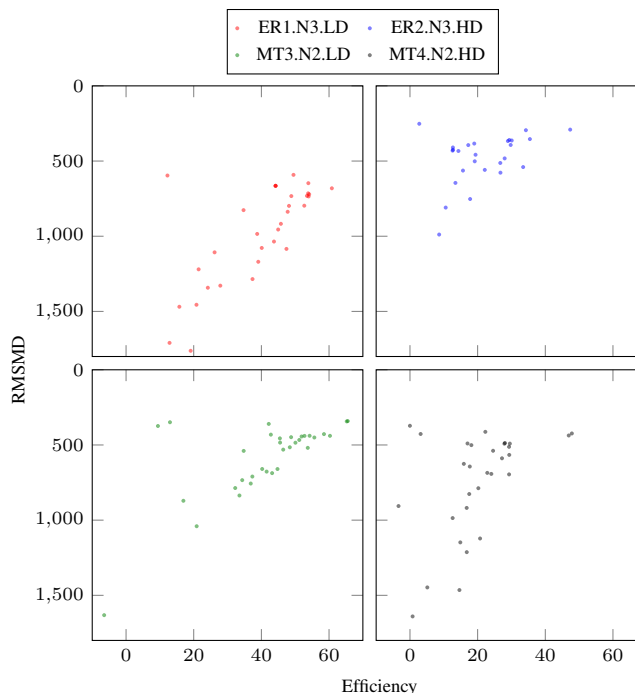


Fig. 4: Low degree of correlation between efficiency and the RMSMD on four datasets from the SMLM 2016 Challenge.

5 Compliance with Ethical Standards

This article does not contain any studies involving human participants or animals performed by any of the authors.

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There is no potential conflict of interest.

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